- 7. A scanning probe microscope comprising:
- a frame:
- a positioning scanner attached to said frame;
- a scanning probe coupled to said positioning scanner;
- at least three support members, each having first and second ends, each engaged with and passing through said frame and including magnetic portions at its second end:
- a sample stage fabricated of a material attracted to said 10 magnetic portions, said sample stage disposed in a stage plane below said scanning probe, said sample stage is removably attached to said support members;
- a cover attached to said frame with a hinge;
- at least one of said support members engaged with a 15 mechanical actuator disposed on said cover; and
- said mechanical actuator provides a drive in a direction generally orthogonal to said stage plane to said at least one of said support members so as to control a distance between said scanning probe and said sample stage.
- 8. A scanning probe microscope according to claim 6 wherein said mechanical actuator is a motor and said motor

16

is engaged with said at least one of said support members through a magnetic clutch.

- 9. A scanning probe microscope according to claim 8 further comprising a chamber removably attached to said frame for surrounding and encapsulating said sample stage.
- 10. A scanning probe microscope according to claim 9 further comprising a glove box loading system be removably attached to said microscope and to surround and hermetically seal a volume containing said chamber, said glove box loading system including:
 - sealing means for hermetically sealing said glove box loading system to said scanning probe microscope, said sealing means being removable from said scanning probe microscope and
 - glove means permitting a user outside said glove box loading system to manipulate items inside said glove box loading system without interrupting the hermetic seal provided by said sealing means.

* * * * *